

Search Notes

Application/Control No.

10/849,319

Examiner

Naheed Ejaz

Applicant(s)/Patent under
Reexamination

CHANG ET AL.

Art Unit

2611

SEARCHED

Class	Subclass	Date	Examiner
375	354,355, 359,371, 373,376	1/30/2008	NE
327	100,141	1/30/2008	NE
327	144,147	1/30/2008	NE
327	156,365	1/30/2008	NE
327	407,291	1/30/2008	NE
327	298	1/30/2008	NE

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST search attached	1/24/2008	NE
Inventorship	1/30/2008	NE
Consulted with SPE Chieh M. Fan	1/30/2008	NE